

1200V 25A Trench and Field Stop IGBT

JJT25N120UH

Key performance:

• $V_{\rm CE} = 1200 \rm V$

• $I_{\rm C}$ =25A@ $T_{\rm C}$ =100°C

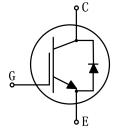
• $V_{\text{CE(sat)}}=2.0\text{V}$

Features:

- Trench and field-stop technology
- High speed switching
- Positive VCE (sat) temperature coefficient.
- Fast switching and short tail current.
- High ruggedness performance

TO-3P





Applications:

Welding machines

Package parameters

Туре	Marking	Package	Packaging Method
JJT25N120UH	T25120UH	TO-3P	Tube



Maximum ratings

Symbol	Parameter	Values	Unit
V_{CES}	Collector-emitter voltage	1200	V
$V_{ m GES}$	Gate-emitter voltage	±20	V
ī	Continuous collector current (T _C =25°C)	50	A
$I_{ m C}$	Continuous collector current (T _C =100°C)	25	A
I_{CM}	Pulsed collector current, t_p limited by T_{vjmax}	100	A
$I_{ m F}$	Diode continuous forward current (T _C =100°C)	25	A
$I_{ m FM}$	Diode maximum current, t_p limited by T_{vjmax}	100	A
D.	Power dissipation ($T_{\rm C}$ =25°C)	375	W
P_{tot}	Power dissipation ($T_{\rm C}$ =100°C)	187	W
$T_{ m vj}$	Operating junction temperature range	-40 to +150	°C
$T_{ m stg}$	Storage temperature range	-55 to +150	°C

Thermal characteristics

Symbol	D	Values		1124
	Parameter	Тур.	Max.	Unit
$R_{ m th(j-c)}$	Thermal resistance, junction to case for IGBT	-	0.4	K/W
$R_{ m th(j-c)}$	Thermal resistance, junction to case for Diode	-	1.0	K/W
$R_{ ext{th(j-a)}}$	Thermal resistance, junction to ambient	-	40	K/W



Electrical characteristics of IGBT $(T_{vj}=25^{\circ}\text{C} \text{ unless otherwise specified})$

Static characteristics

C	Parameter	TD 4 1141	Values			T1 .4
Symbol		Test condition	Min.	Тур.	Max.	Unit
$BV_{\rm CES}$	Collector-emitter breakdown voltage	$V_{\rm GE} = 0 \text{V}, I_{\rm C} = 250 \mu \text{A}$	1200	-	-	V
I_{CES}	Collector-emitter leakage current	$V_{\rm CE}$ =1200V, $V_{\rm GE}$ =0V	-	-	100	μΑ
I	Gate leakage current, forward	$V_{\rm GE} = 20 \text{V}, \ V_{\rm CE} = 0 \text{V}$	-	-	100	nA
$I_{ m GES}$	Gate leakage current, reverse	$V_{\rm GE}$ =-20V, $V_{\rm CE}$ =0V	-	-	-100	nA
$V_{\mathrm{GE(th)}}$	Gate-emitter threshold voltage	$V_{\mathrm{GE}} = V_{\mathrm{CE}}, I_{\mathrm{C}} = 1 \mathrm{mA}$	5.3	5.8	6.8	V
$V_{ m CE(sat)}$		$V_{\rm GE}$ =15 V, $I_{\rm C}$ =25A	-	2.0	-	V
	Collector-emitter saturation voltage	V_{GE} =15V, I_{C} =25A, T_{vj} =175°C	-	2.7	-	V

Dynamic characteristics

Symbol	Parameter	Test condition	Values			TI *4
			Min.	Тур.	Max.	Unit
C_{ies}	Input capacitance	$V_{\rm CE}$ =30V	-	4569	1	pF
$C_{ m oes}$	Output capacitance	V_{CE} =30V V_{GE} =0V f=1MHz	-	60	-	pF
$C_{\rm res}$	Reverse transfer capacitance		-	26	-	pF
$Q_{ m g}$	Total gate charge	V_{CC} =960V V_{GE} =15V I_{C} =25A	-	146	-	nC



Switching characteristics

6 1 1	ymbol Parameter Test condition	The state of the s	Values			Unit
Symbol		lest condition	Min.	Тур.	Max.	Unit
$t_{ m d(on)}$	Turn-on delay time		-	40	-	ns
$t_{ m r}$	Rise time	V _{CC} =600V	-	36	-	ns
$t_{ m d(off)}$	Turn-off delay time	$V_{\text{GE}} = 0/15 \text{V}$ $I_{\text{C}} = 25 \text{A}$	-	169	ı	ns
$t_{ m f}$	Fall time	$R_{\rm G}=10\Omega$	-	68	ı	ns
$E_{ m on}$	Turn-on energy	Inductive load	-	1.4	-	mJ
$E_{ m off}$	Turn-off energy		-	0.8	-	mJ
E_{ts}	Total switching energy		-	2.2	-	mJ
$t_{ m d(on)}$	Turn-on delay time		-	36	-	ns
$t_{ m r}$	Rise time	V _{CC} =600V	-	31	-	ns
$t_{ m d(off)}$	Turn-off delay time	$V_{\rm GE} = 0/15 { m V}$	-	195	-	ns
$t_{ m f}$	Fall time	$I_{\rm C}$ =25A $R_{\rm G}$ =10 Ω Inductive load $T_{\rm vj}$ =175 °C	-	134	-	ns
$E_{ m on}$	Turn-on energy		-	1.5	-	mJ
$E_{ m off}$	Turn-off energy		-	1.1	-	mJ
$E_{ m ts}$	Total switching energy		-	2.6	-	mJ



Electrical characteristics of Diode $(T_{vj}=25^{\circ}\mathbb{C} \text{ unless otherwise specified})$

Ch - l	Parameter	Test condition	Values			TT .*4
Symbol			Min.	Тур.	Max.	Unit
IV.	$V_{ m F}$ Diode forward voltage	$I_{\rm F}$ =25A	-	2.6	-	V
V F		$I_{\rm F}$ =25A, $T_{\rm vj}$ =175°C	-	2.3	-	V
$t_{ m rr}$	Diode reverse recovery time	$V_{\rm R}$ =600V $I_{\rm F}$ =25A $di_{\rm F}/dt$ =-600A/ μ s	-	120	-	ns
$I_{ m rrm}$	Diode peak reverse recovery current		-	13	-	A
$Q_{ m rr}$	Diode reverse recovery charge		-	1020	-	nC
$t_{ m rr}$	Diode reverse recovery time	$V_{\rm R}$ =600V $I_{\rm F}$ =25A $di_{\rm F}/dt$ =-600A/μs $T_{\rm vj}$ =175°C	-	167	-	ns
$I_{ m rrm}$	Diode peak reverse recovery current		-	19	-	A
$Q_{ m rr}$	Diode reverse recovery charge		-	2760	-	пC



Typical performance characteristics

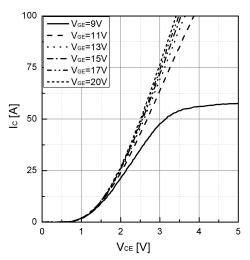


Fig 1. Typical output characteristic (T_{vj} =25°C)

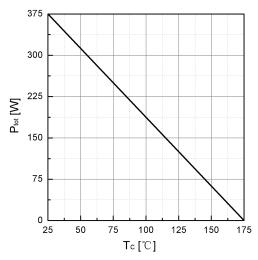


Fig 3. Power dissipation as a function of T_C

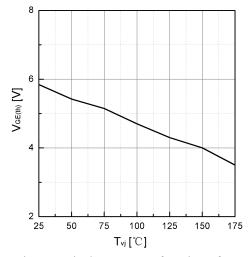


Fig 5. Typical $V_{\text{GE(th)}}$ as a function of T_{vj} ($I_{\text{C}}=1\,\text{mA}$)

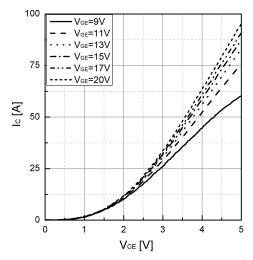


Fig 2. Typical output characteristic(T_{vj} =175°C)

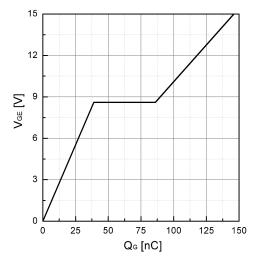


Fig 4. Typical Gate charge

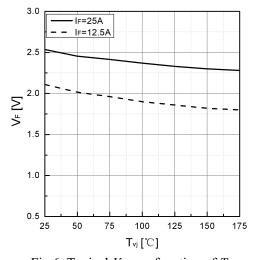


Fig 6. Typical V_F as a function of T_{vj}



Typical performance characteristics

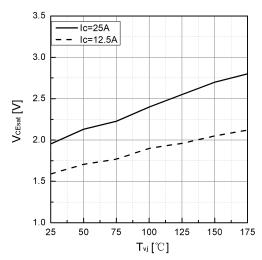


Fig 7. Typical V_{CEsat} as a function of T_{vj}

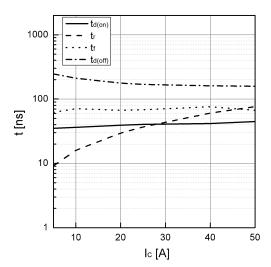


Fig 9. Typical switching time as a function of $I_{\rm C}$

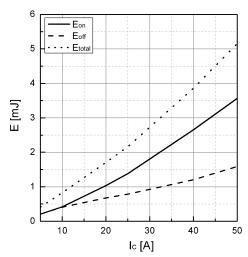


Fig 11. Typical switching energy losses as a function of $I_{\mathbb{C}}$

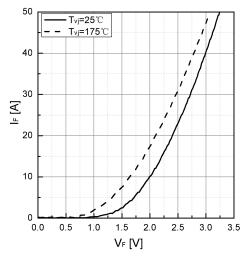


Fig 8. Typical I_F as a function of V_F

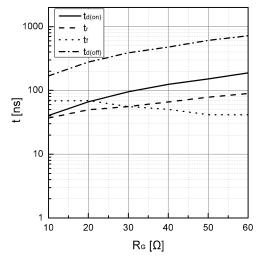


Fig 10. Typical switching times as a function of R_G

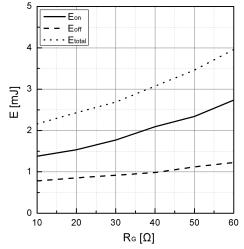


Fig 12. Typical switching energy losses as a function of R_G



Typical performance characteristics

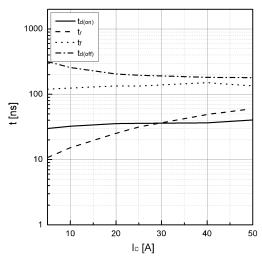


Fig 13. Typical switching time as a function of $I_{\mathbb{C}}$

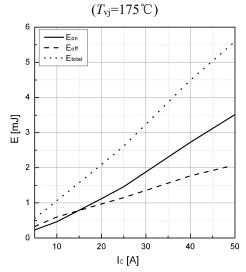


Fig 15. Typical switching energy losses as a function of $I_{\mathbb{C}}(T_{vj}=175^{\circ}\mathbb{C})$

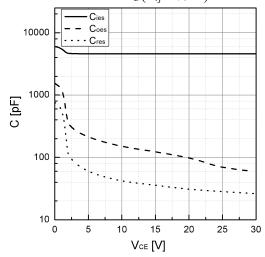


Fig 17. Typical capacitance as a function of $V_{\rm CE}$ (f=1Mhz, $V_{\rm GE}$ =0V)

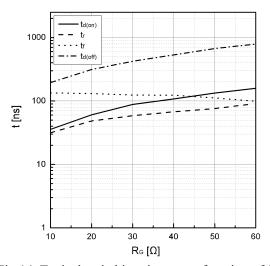


Fig 14. Typical switching times as a function of $R_{\rm G}$

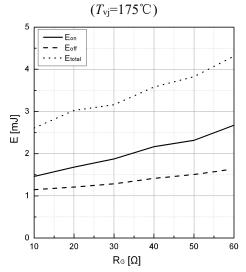
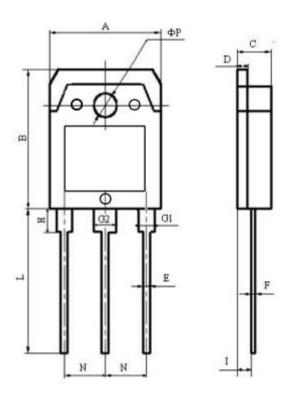


Fig 16. Typical switching energy losses as a function of $R_G(T_{vj}=175^{\circ}C)$



Package dimension

TO-3P



Items	Valu	es(mm)
Tems	MIN	MAX
A	15.00	16.00
В	19.20	20.60
С	4.60	5.00
D	1.40	1.60
Е	0.90	1.10
F	0.50	0.70
G1	2.00	2.20
G2	3.00	3.20
Н	3.00	3.70
I	2.30	2.50
L*	19.00	21.00
N	5.25	5.65
фР	3.10	3.30



Revision history

Date	Revision	Changes
2024-09-23	Rev 1.0	Release of the datasheet

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